

FCC - TEST REPORT

Report Number : 60.790.16.716.01 Date of Issue: June 2, 2016Model : SH002Product Type : VerveLoop+Applicant : Binatone Electronics International Ltd.Address : Floor 23A, 9 Des Voeux Road West, Sheung Wan, Hong Kong
ChinaProduction Facility : Charter Media (Dongguan) Co., Ltd.Address : Dabandi Industrial Zone, Daning District, Humen Town,
Dongguan City, Guangdong Province 523930, P. R. ChinaTest Result : **Positive** **Negative**Total pages including
Appendices : 49

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2 Details about the Test Laboratory

Details about the Test Laboratory

Test Site 1

Company name: TÜV SÜD Hong Kong Ltd.
3/F, West Wing, Lakeside 2,
10 Science Park West Avenue,
Science Park, Shatin, Hong Kong

Test Site 2

Company name: Hong Kong Productivity Council
LG1, HKPC Building,
78 Tat Chee Avenue,
Kowloon, Hong Kong

FCC Registration Number: 90656

IC Registration Number : 4780A

3 Description of the Equipment Under Test

Product:	VerveLoop+
Model no.:	SH002
Options and accessories:	Nil
Rating:	DC3.7V Supplied by Li-ion Rechargeable Battery DC5.0V Charged by the mini-USB port
RF Transmission Frequency:	2402MHz-2480MHz
No. of Operated Channel:	79
Modulation:	GFSK, $\pi/4$ -DQPSK, 8-DPSK
Antenna Type:	Chip antenna
Antenna Gain:	1.6dBi
Description of the EUT:	The Equipment Under Test (EUT) is a Bluetooth headset operated at 2.4GHz

4 Summary of Test Standards

Test Standards	
FCC Part 15 Subpart C 10-1-2015 Edition	PART 15 - RADIO FREQUENCY DEVICES Subpart C - Intentional Radiators
RSS-247 Issue 1 2015	Digital Transmission Systems (DTSS), Frequency Hopping Systems (FHSS) and License-Exempt Local Area Network (LE-LAN) Devices

All the test methods were according to Public Notice DA 00-705 -Frequency Hopper Spread Spectrum Test Procedure released by FCC on March 30, 2000 and ANSI C63.10-2013.

5 Summary of Test Results

Technical Requirements					
FCC Part 15 Subpart C/RSS-247 Issue 1/RSS-Gen Issue 4					
Test Condition			Pages	Test Result	Test Site
§15.207	RSS-GEN 8.8	Conducted emission AC power port	10	Pass	Site 2
§15.247(b)(1)	RSS-247 Clause 5.4(2)	Conducted peak output power	13	Pass	Site 2
§15.247(e)	RSS-247 Clause 5.2(2)	Power spectral density*	--	N/A	--
§15.247(a)(2)	RSS-247 Clause 5.2(1)	6dB bandwidth	--	N/A	--
§15.247(a)(1)	RSS-247 Clause 5.1(1)	20dB bandwidth and 99% Occupied Bandwidth	20	Pass	Site 2
§15.247(a)(1)	RSS-247 Clause 5.1(2)	Carrier frequency separation	27	Pass	Site 2
§15.247(a)(1)(iii)	RSS-247 Clause 5.1(4)	Number of hopping frequencies	30	Pass	Site 2
§15.247(a)(1)(iii)	RSS-247 Clause 5.1(4)	Dwell Time	32	Pass	Site 2
§15.247(d)	RSS-247 Clause 5.5	Spurious RF conducted emissions	35	Pass	Site 2
§15.247(d)	RSS-247 Clause 5.5	Band edge	39	Pass	Site 2
§15.247(d) & §15.209 &	RSS-247 Clause 5.5 & RSS-GEN 6.13	Spurious radiated emissions for transmitter and receiver	44	Pass	Site 2
§15.203	RSS-GEN 8.3	Antenna requirement	See note 1	Pass	--

Note 1: N/A=Not Applicable.

Note 2: The EUT uses a Chip antenna, which gain is 1.6dBi. In accordance to §15.203, it is considered sufficiently to comply with the provisions of this section.

6 General Remarks

Remarks

This submittal(s) (test report) is intended for FCC ID: VLJ-SH002, IC: 4522A-SH002 complies with Section 15.207, 15.209, 15.247 of the FCC Part 15, Subpart C, RSS 247 and RSS-Gen rules.

SUMMARY:

All tests according to the regulations cited on page 5 were

■ - Performed

□ - **Not** Performed

The Equipment Under Test

■ - **Fulfills** the general approval requirements.

□ - **Does not** fulfill the general approval requirements.

Sample Received Date: May 9, 2016

Testing Start Date: May 9, 2016

Testing End Date: May 28, 2016

- TÜV SÜD HONG KONG LTD. -

Reviewed by:



Phoebe Hu
EMC Project Manager

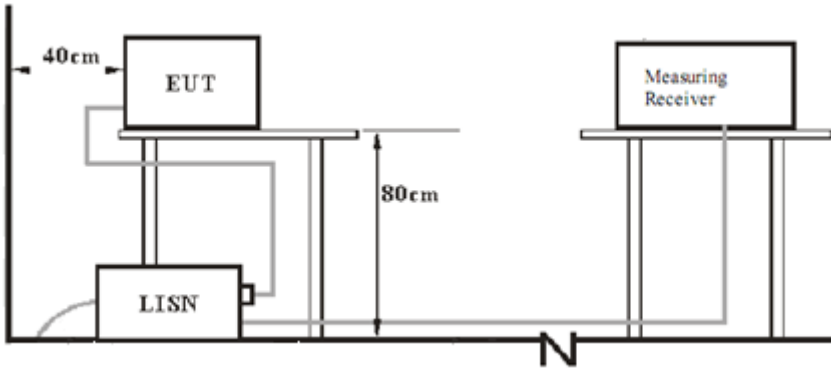
Prepared by:



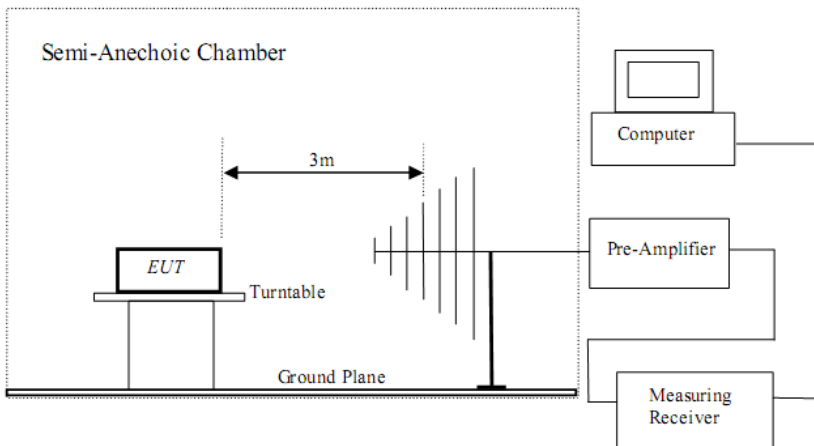
Felix Li
Senior EMC Project Engineer

7 Test Setups

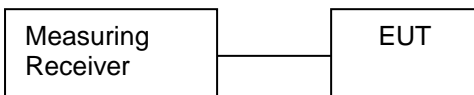
7.1 AC Power Line Conducted Emission test setups



7.2 Radiated test setups



7.3 Conducted RF test setups



8 Systems test configuration

Auxiliary Equipment Used during Test:

DESCRIPTION	MANUFACTURER	MODEL NO.	S/N
PC	lenovo	X220	---

Test software: Blue test 3.0, which used to control the EUT in continues transmitting mode

The system was configured to hopping mode and non-hopping mode.

Hopping mode: typical working mode (normal hopping status)

Non-hopping mode: The system was configured to operate at a signal channel transmitting. The test software allows the configuration and operation at the worst-case duty and the highest transmit power

9 Technical Requirement

9.1 Conducted Emission

Test Method

1. The EUT was placed on a table, which is 0.8m above ground plane
2. The power line of the EUT is connected to the AC mains through a Artificial Mains Network (A.M.N.).
3. Maximum procedure was performed to ensure EUT compliance
4. A EMI test receiver is used to test the emissions from both sides of AC line

Limit

Frequency MHz	QP Limit dB μ V	AV Limit dB μ V
0.150-0.500	66-56*	56-46*
0.500-5	56	46
5-30	60	50

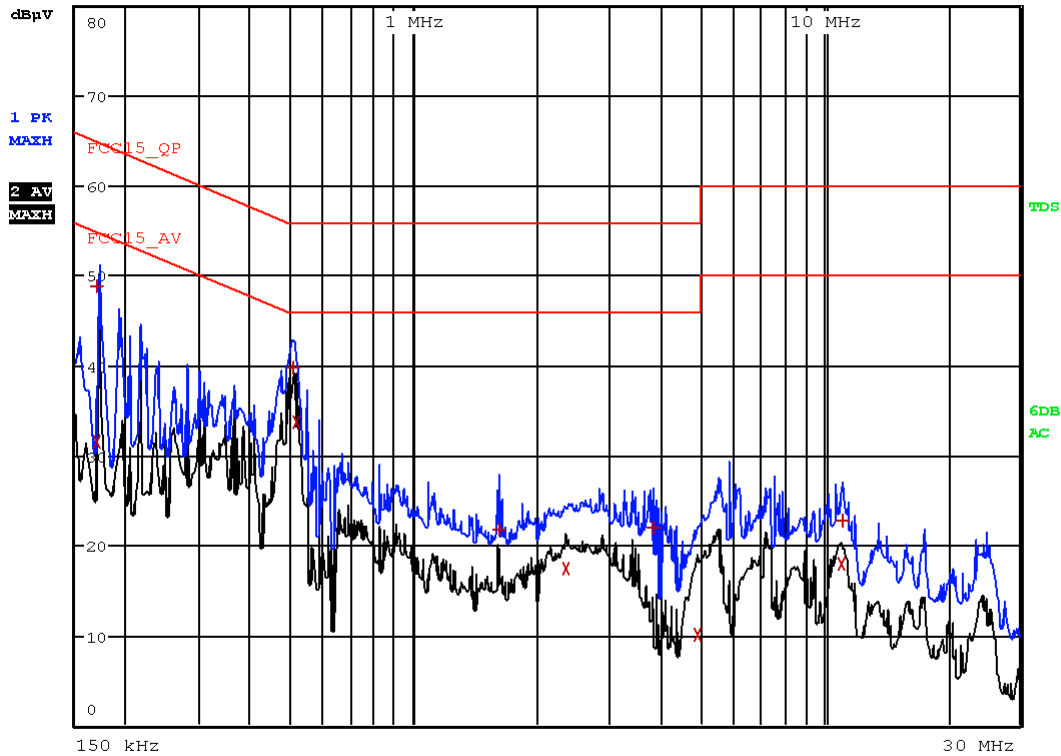
Decreasing linearly with logarithm of the frequency

Conducted Emission

Product Type : VerveLoop+
 M/N : SH002
 Operating Condition : Charging & BT
 Test Specification : Live
 Comment : AC 120V/60Hz



RBW 9 kHz
 MT 1 s
 Att 0 dB AUTO PREAMP OFF



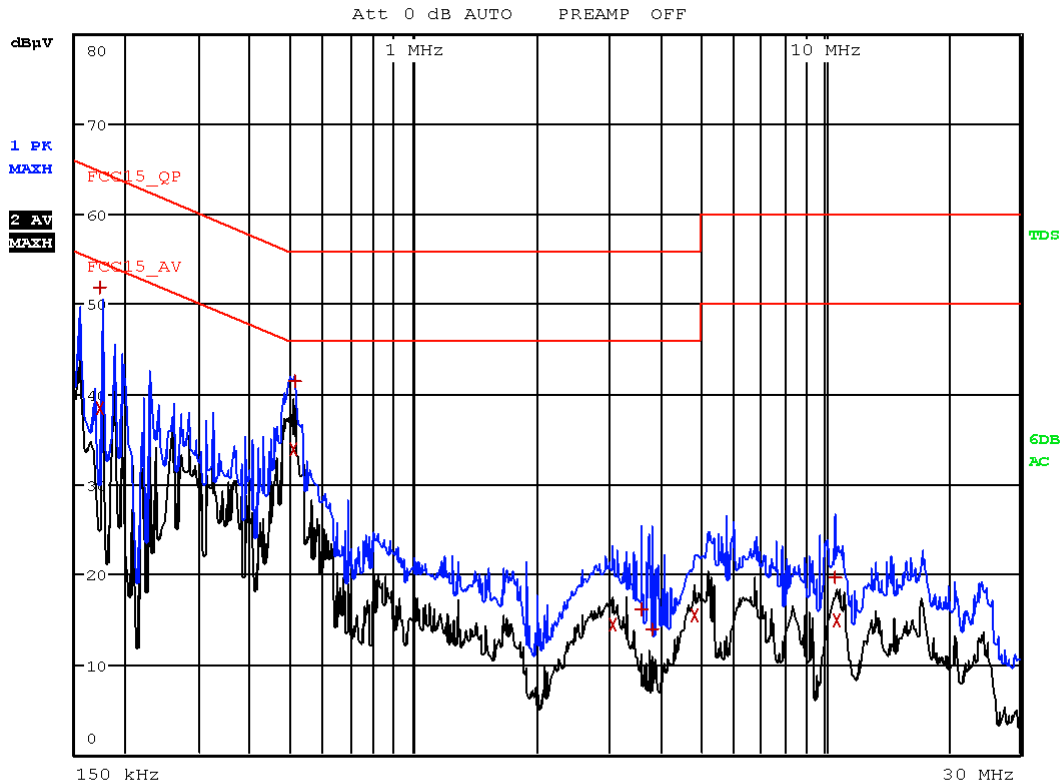
Trace	Frequency	Level (dBµV)	Detector	Delta Limit/dB
1	170.00000000 kHz	48.88	Quasi Peak	-16.08
2	170.00000000 kHz	31.56	Average	-23.40
1	506.00000000 kHz	39.75	Quasi Peak	-16.25
2	514.00000000 kHz	33.75	Average	-12.25
1	1.61400000 MHz	21.73	Quasi Peak	-34.27
2	2.33800000 MHz	17.32	Average	-28.68
1	3.83400000 MHz	21.86	Quasi Peak	-34.14
2	4.91400000 MHz	9.98	Average	-36.02
2	11.05000000 MHz	17.88	Average	-32.12
1	11.07000000 MHz	22.74	Quasi Peak	-37.26

Conducted Emission

Product Type : VerveLoop+
 M/N : SH002
 Operating Condition : Charging & BT
 Test Specification : Neutral
 Comment : AC 120V/60Hz



RBW 9 kHz
 MT 1 s
 PREAMP OFF



Trace	Frequency	Level (dBµV)	Detector	Delta Limit/dB
1	174.00000000 kHz	51.77	Quasi Peak	-12.99
2	174.00000000 kHz	38.39	Average	-16.38
2	506.00000000 kHz	33.81	Average	-12.19
1	510.00000000 kHz	41.48	Quasi Peak	-14.52
2	3.04200000 MHz	14.41	Average	-31.59
1	3.59800000 MHz	15.99	Quasi Peak	-40.01
1	3.80600000 MHz	13.83	Quasi Peak	-42.17
2	4.84200000 MHz	15.41	Average	-30.59
1	10.68200000 MHz	19.63	Quasi Peak	-40.37
2	10.73800000 MHz	14.90	Average	-35.10

9.2 Conducted peak output power

Test Method

1. Use the following spectrum analyzer settings:
Span = approximately 5 times the 20 dB bandwidth, centered on a hopping channel
RBW > the 20 dB bandwidth of the emission being measured, VBW \geq RBW,
Sweep = auto, Detector function = peak, Trace = max hold
2. Add a correction factor to the display.
3. Allow the trace to stabilize. Use the marker-to-peak function to set the marker to the peak of the emission. The indicated level is the peak output power

Limits

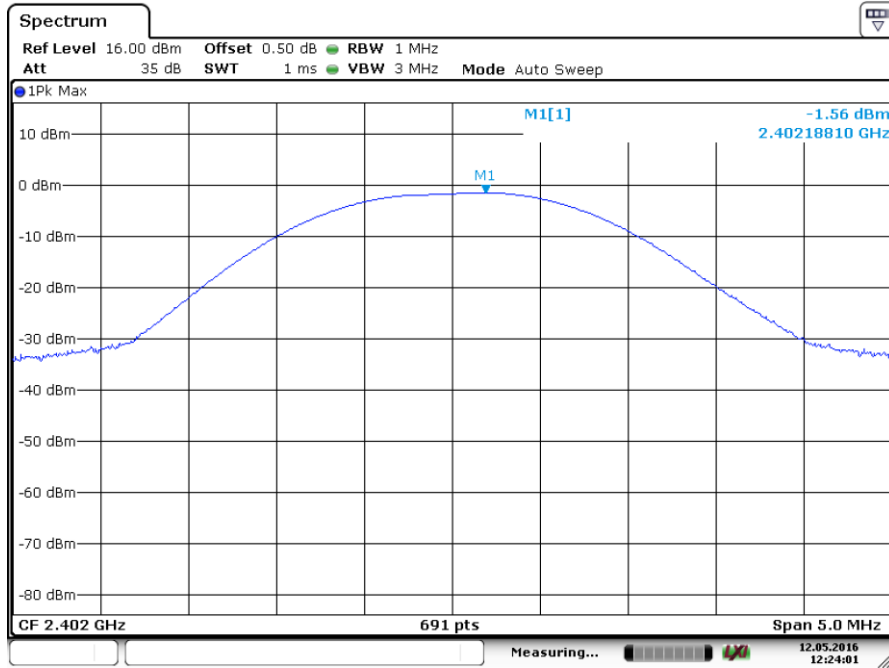
Frequency Range MHz	Limit W	Limit dBm
2400-2483.5	≤ 1	≤ 30

Conducted peak output power

Bluetooth Mode GFSK modulation Test Result

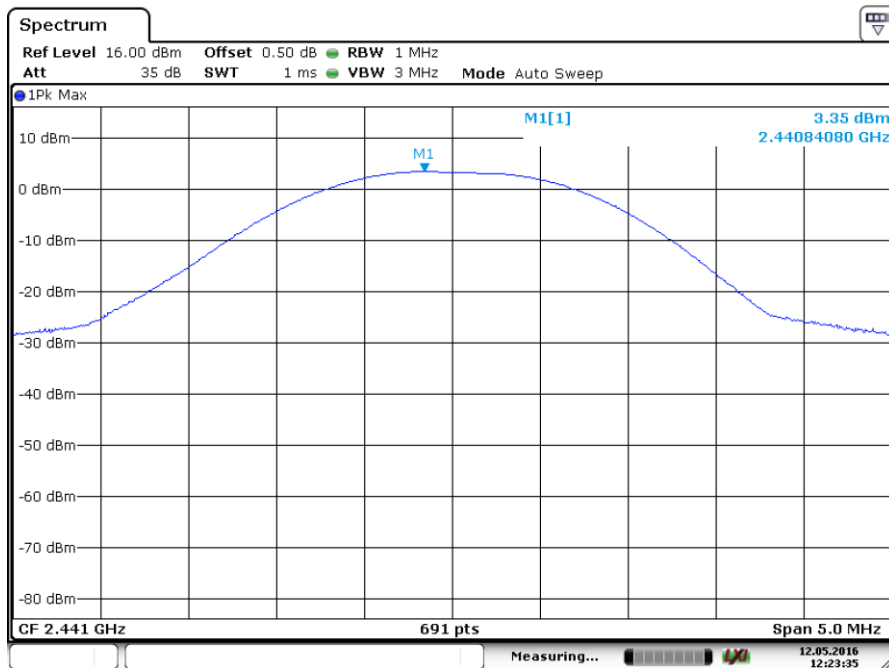
Frequency MHz	Conducted Peak Output Power dBm	Result
Low channel 2402MHz	-1.56	Pass
Middle channel 2441MHz	3.35	Pass
High channel 2480MHz	3.53	Pass

Low channel 2402MHz



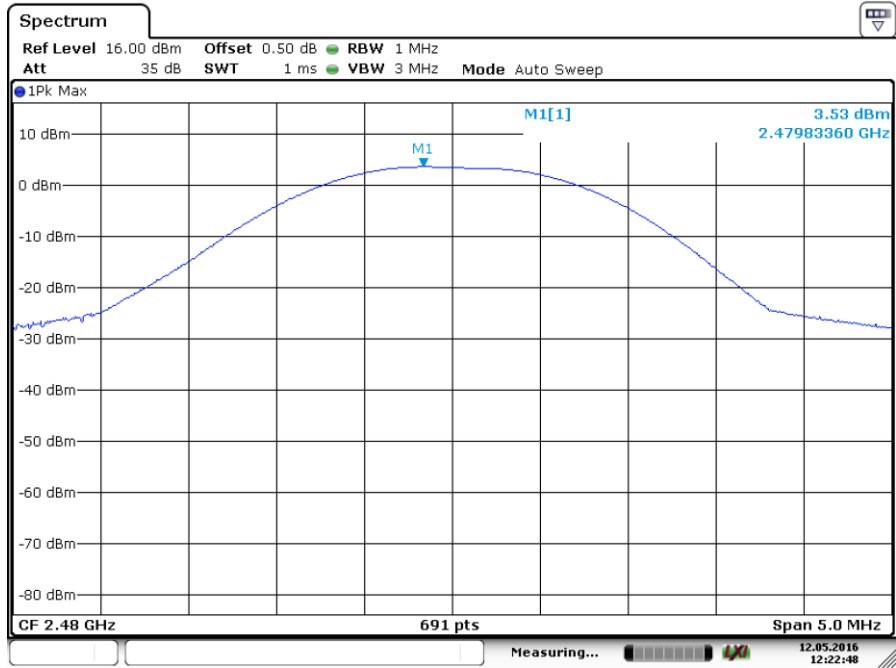
Date: 12.MAY.2016 12:24:01

Middle channel 2441MHz



Date: 12.MAY.2016 12:23:36

High channel 2480MHz

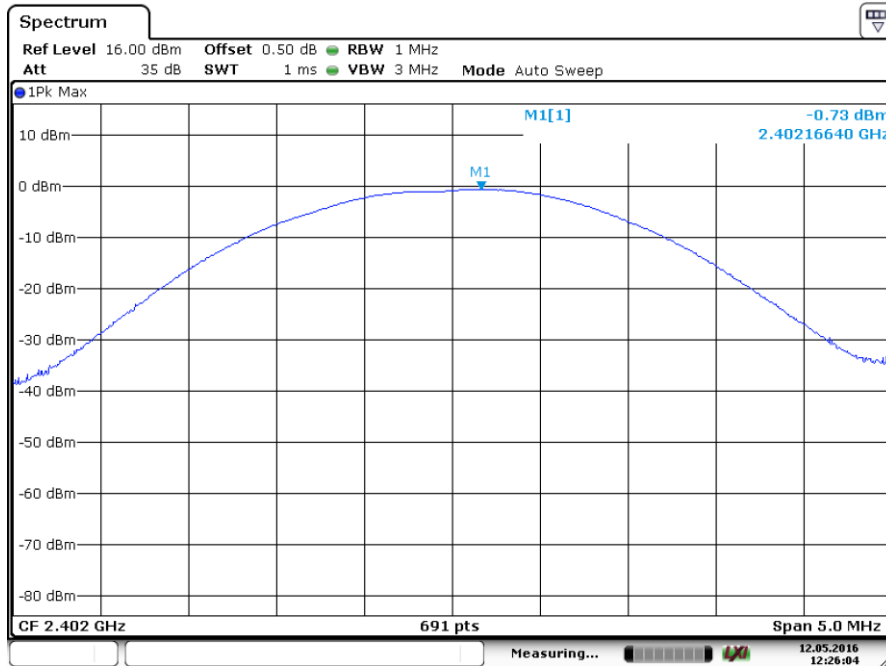


Date: 12.MAY.2016 12:22:49

Bluetooth Mode $\pi/4$ -DQPSK modulation Test Result

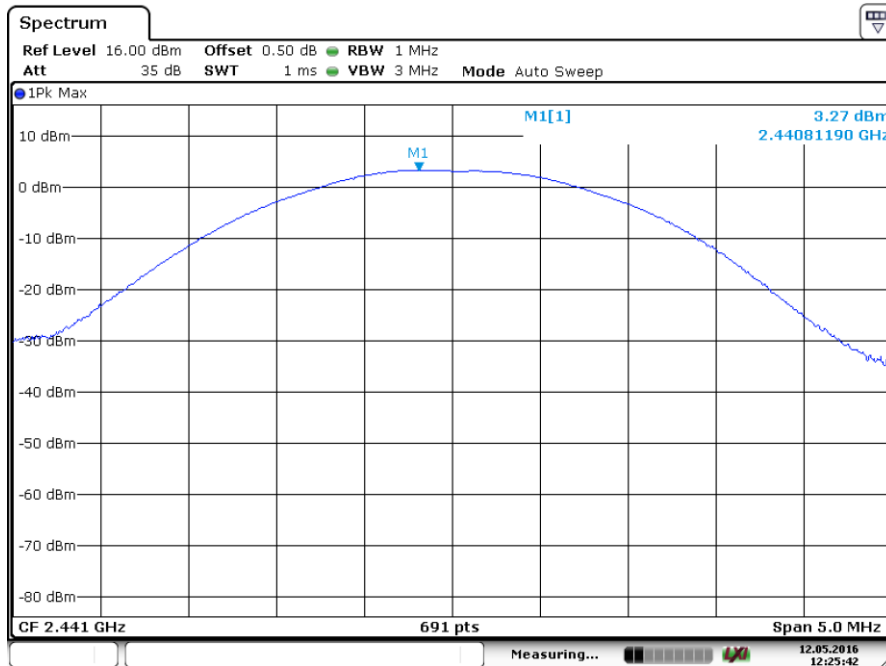
Frequency MHz	Conducted Peak Output Power dBm	Result
Low channel 2402MHz	-0.73	Pass
Middle channel 2441MHz	3.27	Pass
High channel 2480MHz	3.57	Pass

Low channel 2402MHz



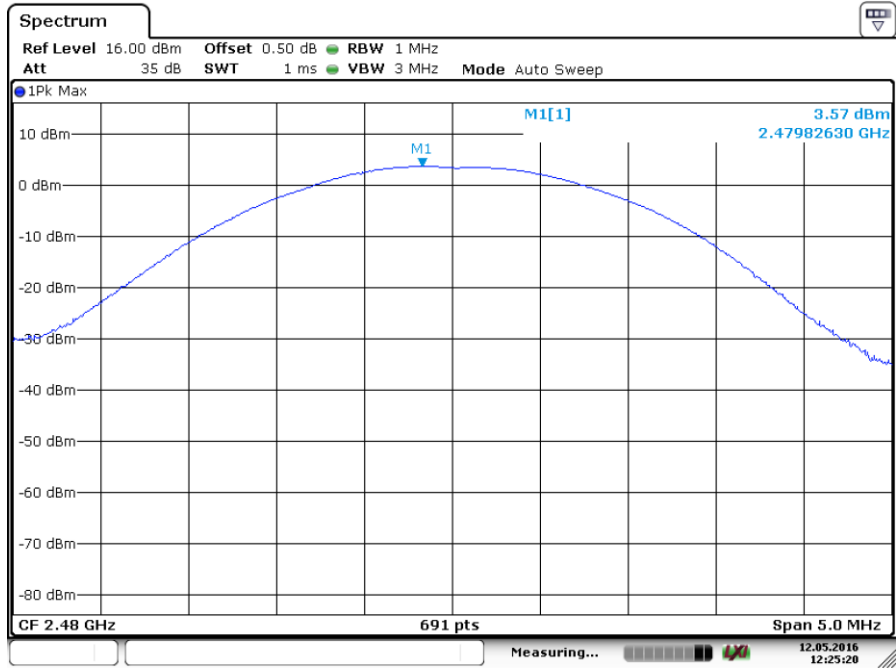
Date: 12.MAY.2016 12:26:04

Middle channel 2441MHz



Date: 12.MAY.2016 12:25:42

High channel 2480MHz

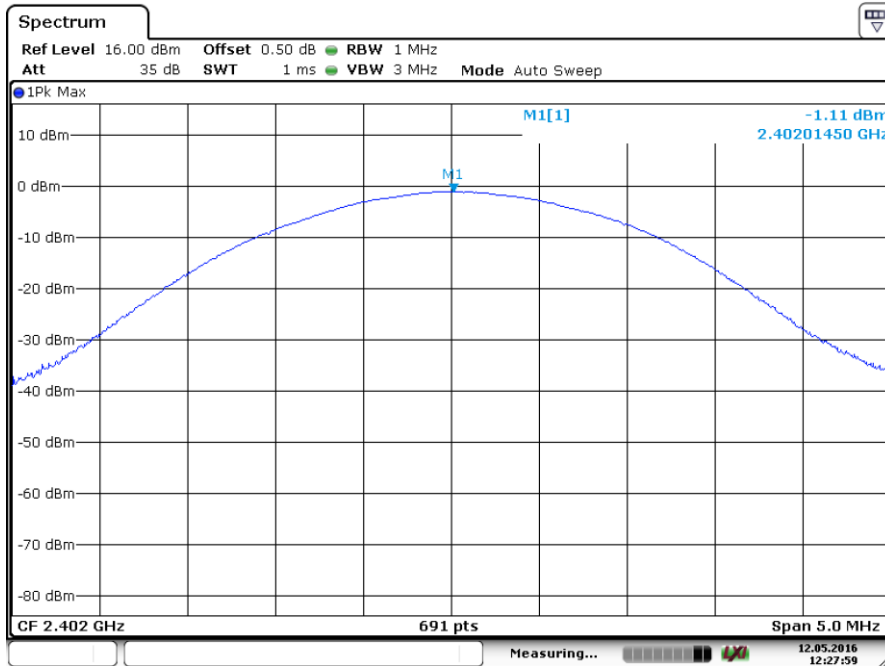


Date: 12.MAY.2016 12:25:20

Bluetooth Mode 8DPSK modulation Test Result

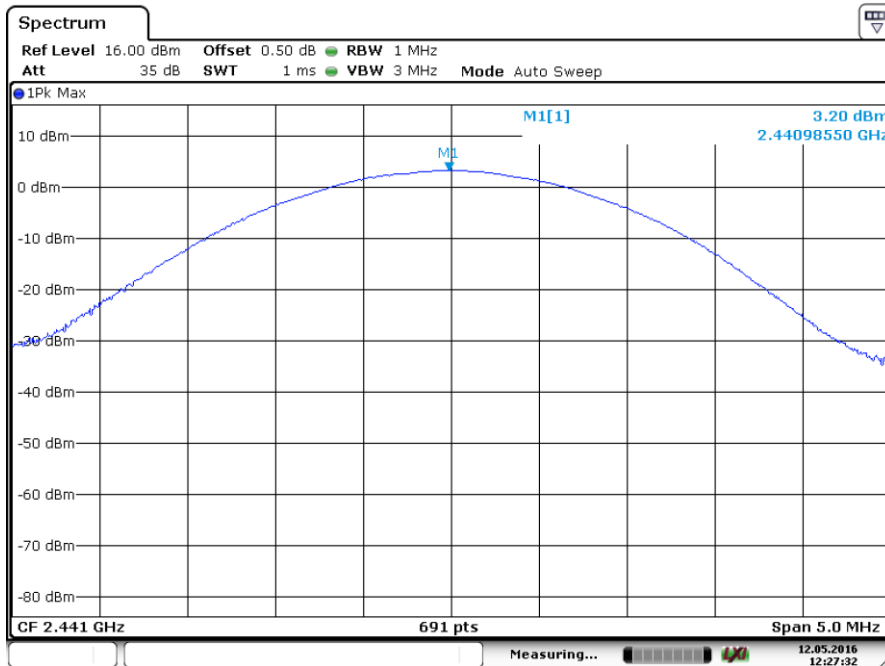
Frequency MHz	Conducted Peak Output Power dBm	Result
Low channel 2402MHz	-1.11	Pass
Middle channel 2441MHz	3.20	Pass
High channel 2480MHz	3.47	Pass

Low channel 2402MHz



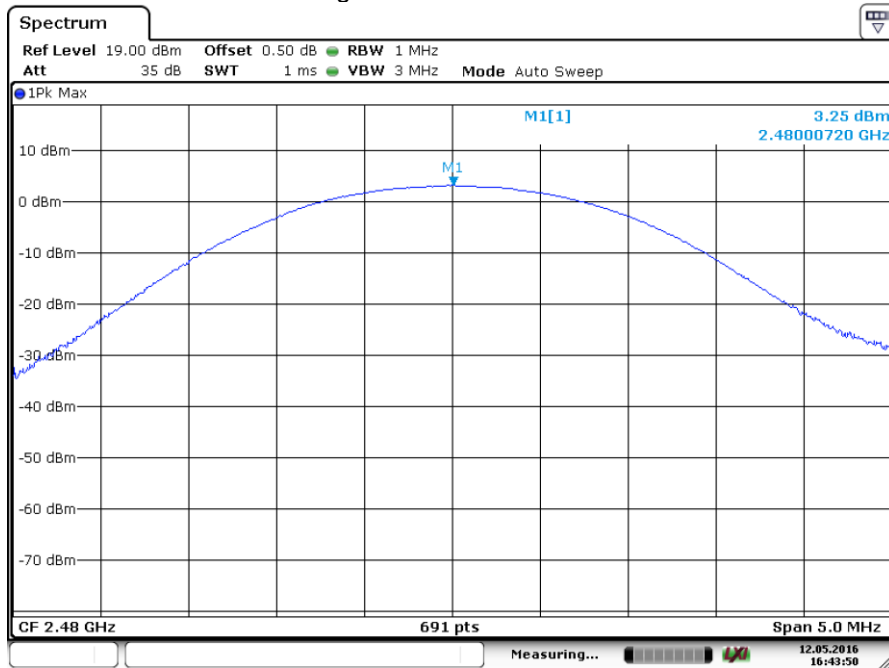
Date: 12.MAY.2016 12:27:59

Middle channel 2441MHz

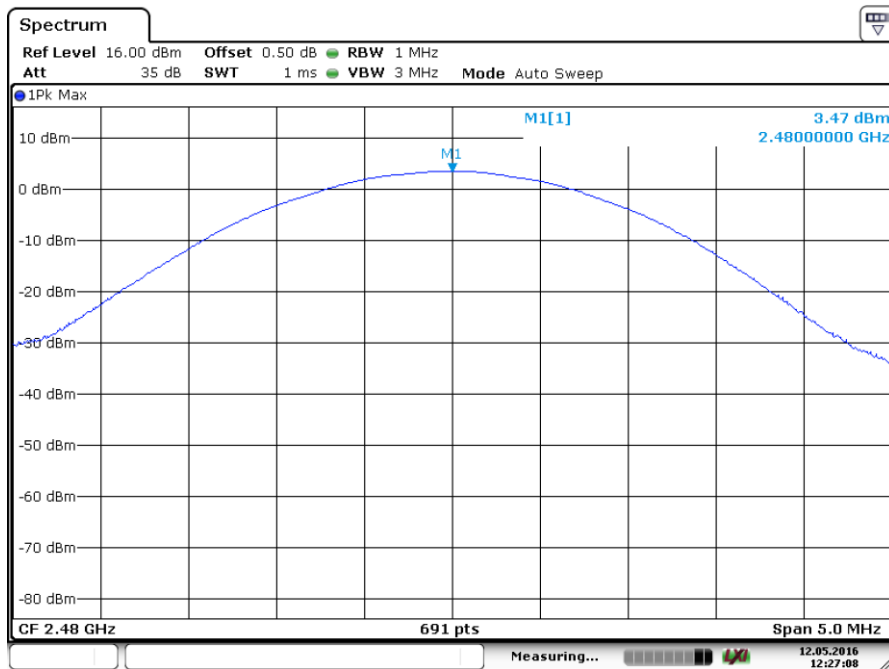


Date: 12.MAY.2016 12:27:33

High channel 2480MHz



Date: 12.MAY.2016 16:43:50



Date: 12.MAY.2016 12:27:08

9.3 20 dB bandwidth and 99% Occupied Bandwidth

Test Method

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT without connection to measurement instrument. Turn on the EUT and connect it to measurement instrument. Then set it to any one convenient frequency within its operating range. Set a reference level on the measuring instrument equal to the highest peak value.
3. Measure the frequency difference of two frequencies that were attenuated 20 dB from the reference level. Record the frequency difference as the emission bandwidth.
4. Repeat above procedures until all frequencies measured were complete.

Limit

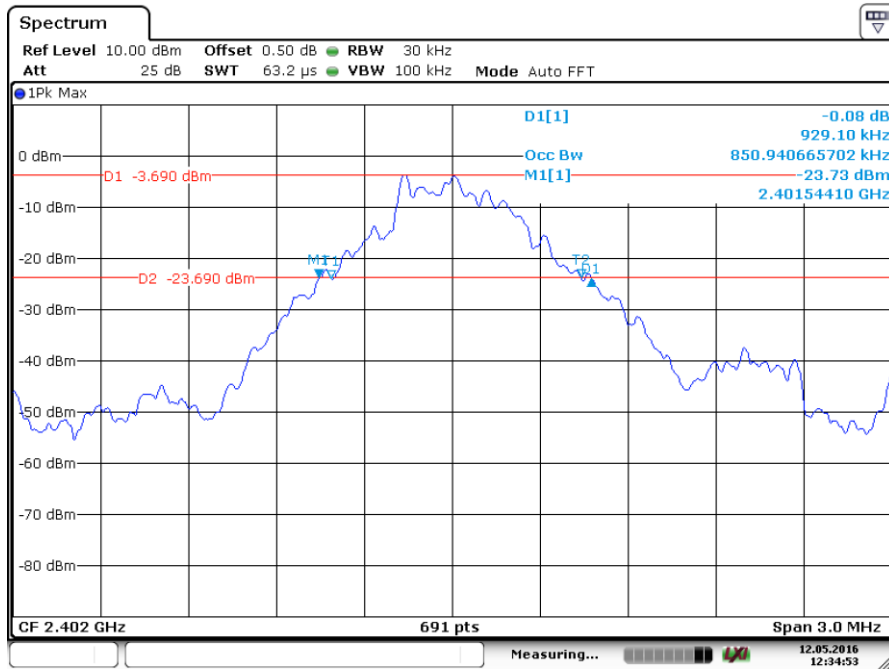
Limit [kHz]

N/A

20 dB bandwidth and 99% Occupied Bandwidth

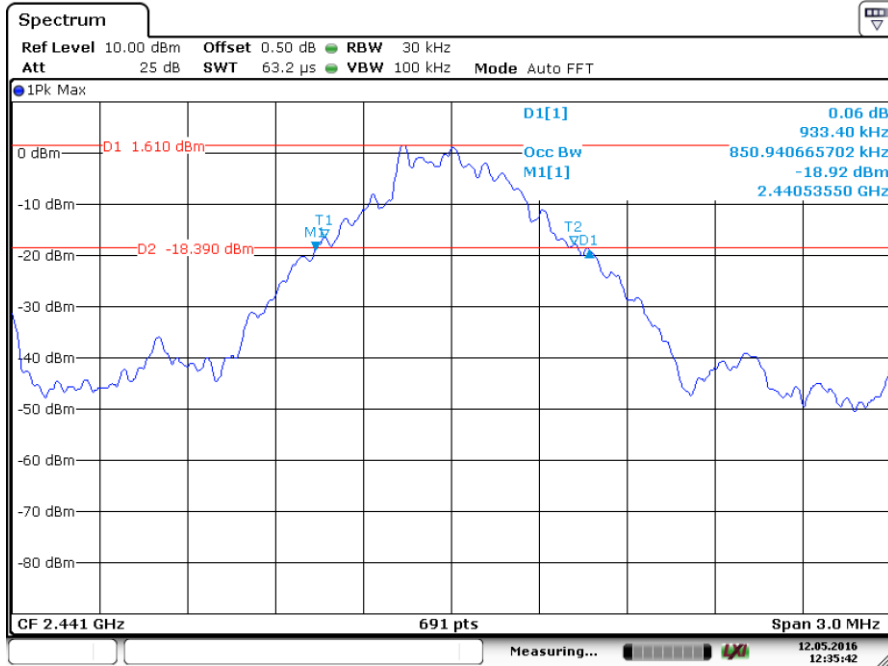
Bluetooth Mode GFSK Modulation test result

Frequency MHz	20 dB Bandwidth kHz	99% Bandwidth kHz	Limit kHz	Result
2402	929.10	850.94	--	Pass
2441	933.40	850.94	--	Pass
2480	924.70	846.40	--	Pass



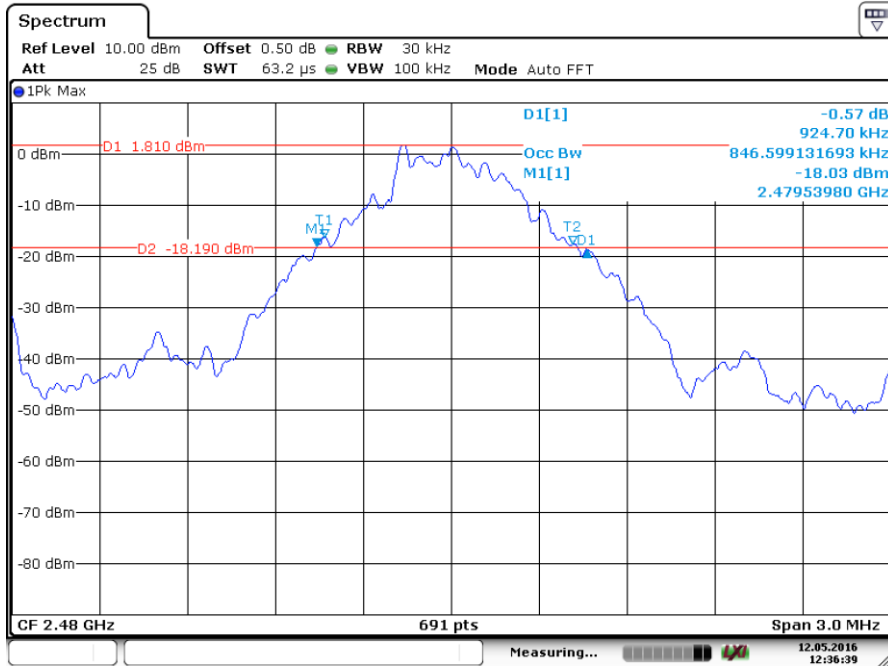
Date: 12.MAY.2016 12:34:53

2441MHz



Date: 12.MAY.2016 12:35:42

2480MHz



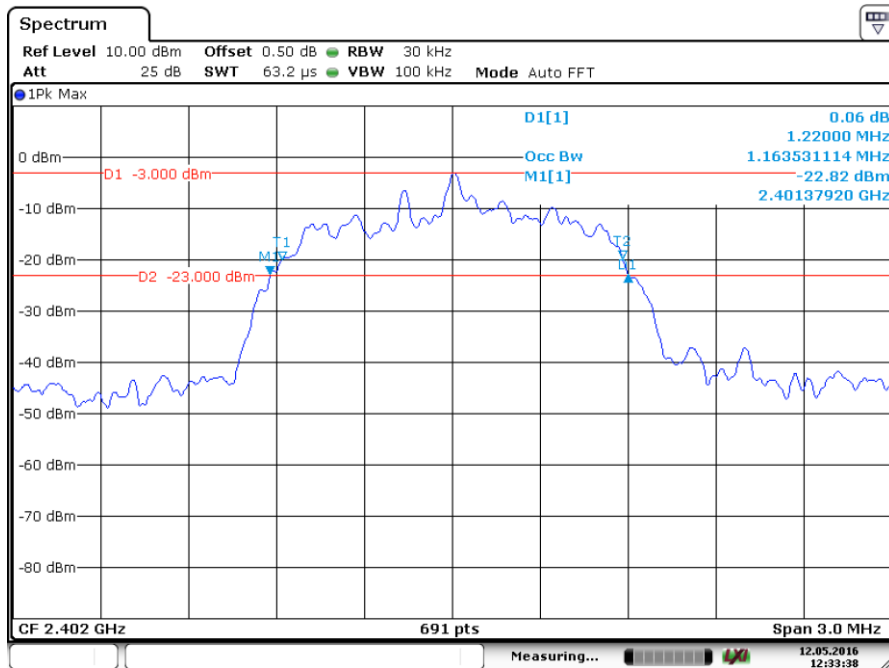
Date: 12.MAY.2016 12:36:40

20 dB bandwidth and 99% Occupied Bandwidth

Bluetooth Mode $\pi/4$ -DQPSK Modulation test result

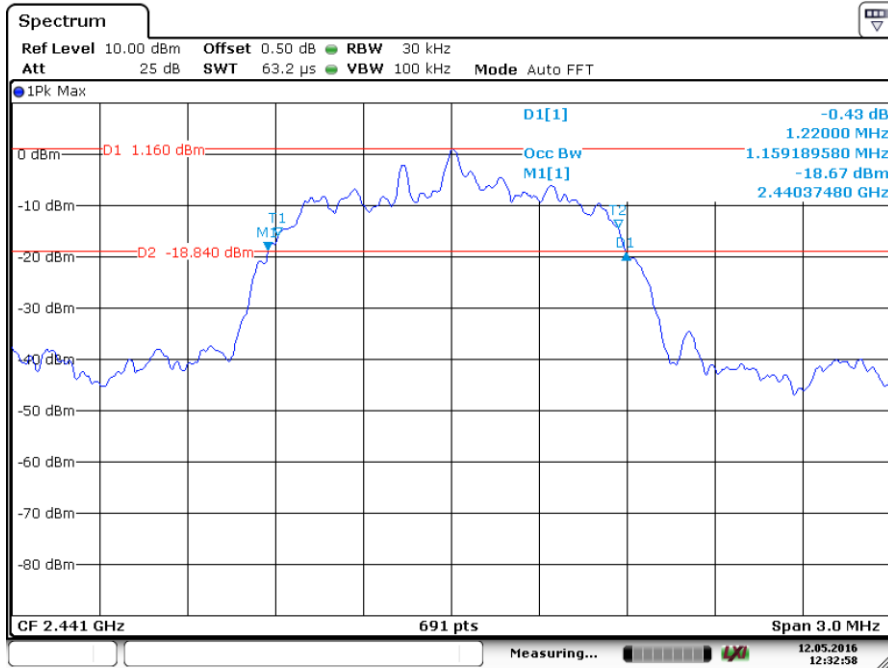
Frequency MHz	20 dB Bandwidth kHz	99% Bandwidth kHz	Limit kHz	Result
2402	1220.0	1163.50	--	Pass
2441	1220.0	1159.19	--	Pass
2480	1224.3	1159.19	--	Pass

2402MHz



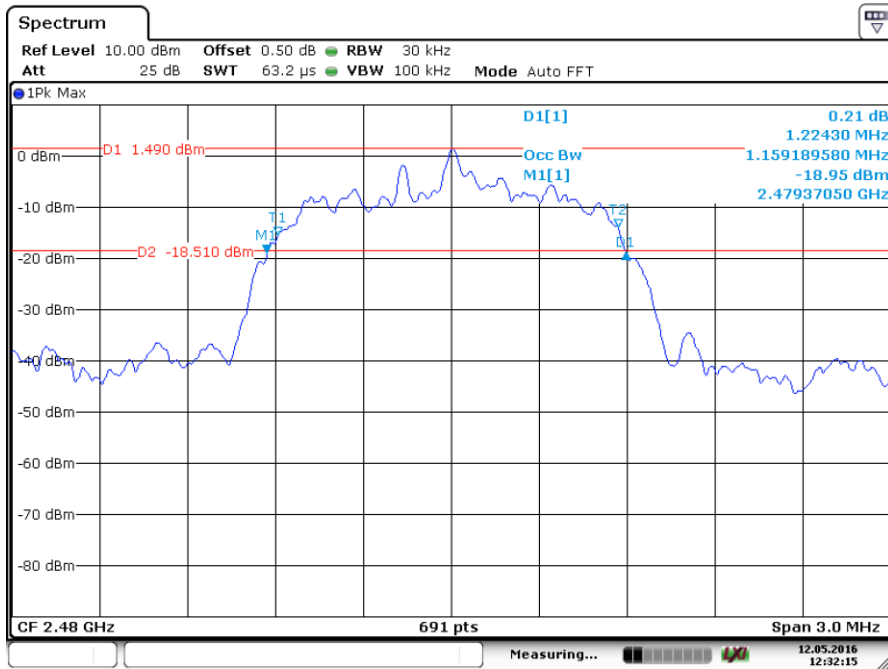
Date: 12.MAY.2016 12:33:38

2441MHz



Date: 12.MAY.2016 12:32:58

2480MHz



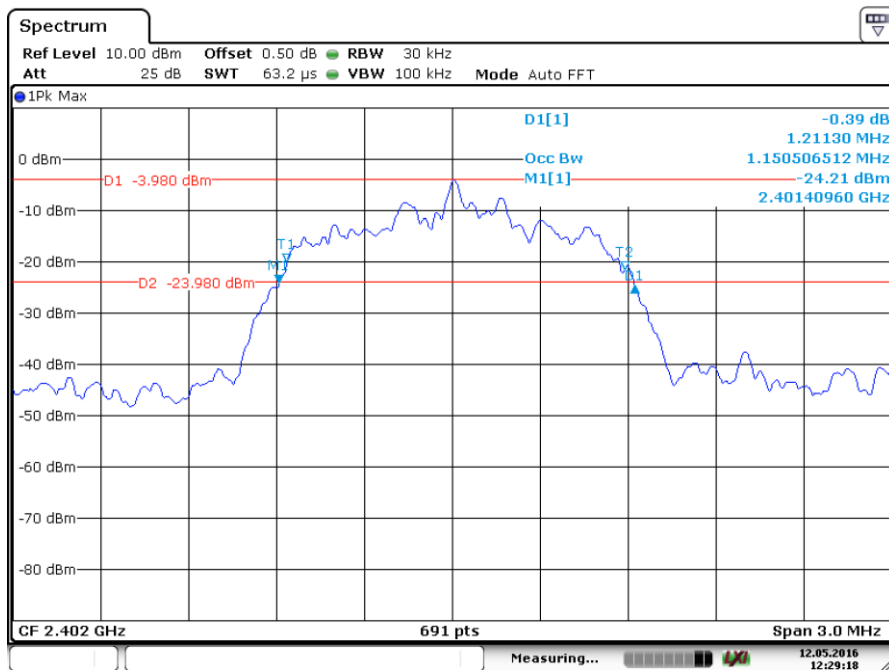
Date: 12.MAY.2016 12:32:15

20 dB bandwidth and 99% Occupied Bandwidth

Bluetooth Mode 8DPSK Modulation test result

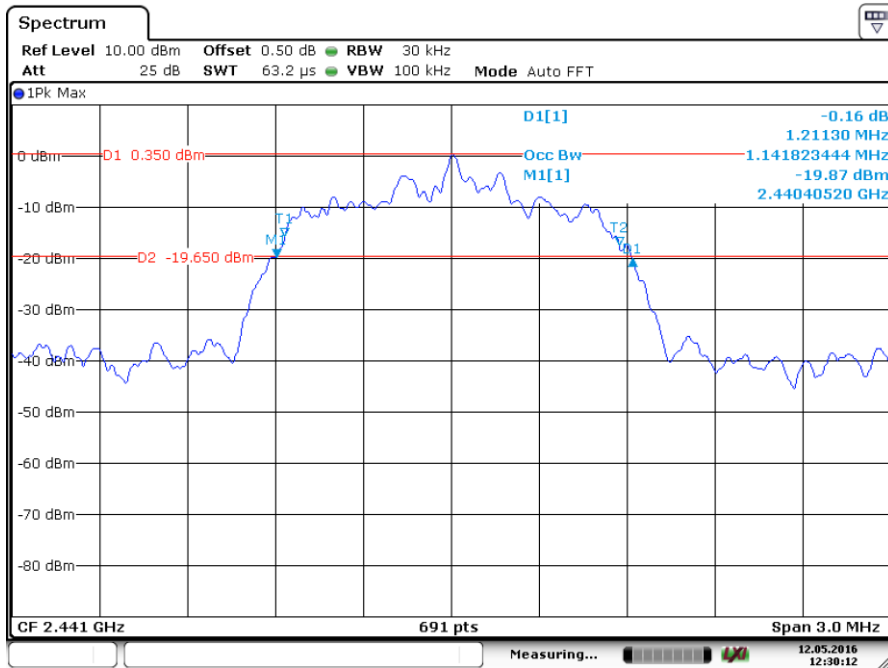
Frequency MHz	20 dB Bandwidth kHz	99% Bandwidth kHz	Limit kHz	Result
2402	1211.3	1150.51	--	Pass
2441	1211.3	1141.82	--	Pass
2480	1211.3	1146.16	--	Pass

2402MHz



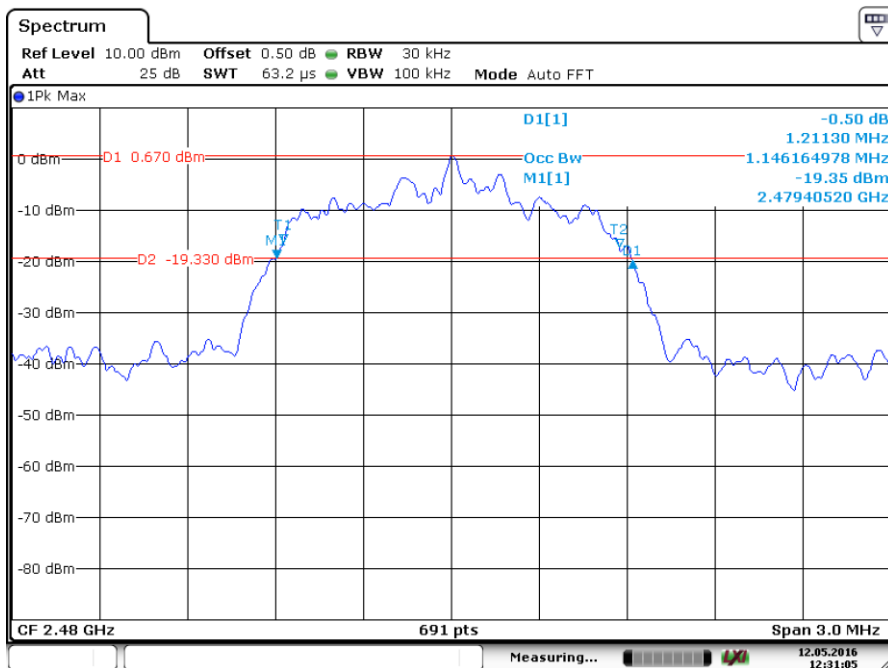
Date: 12.MAY.2016 12:29:18

2441MHz



Date: 12.MAY.2016 12:30:12

2480MHz



Date: 12.MAY.2016 12:31:05

9.4 Carrier Frequency Separation

Test Method

1. Use the following spectrum analyzer settings:
Span = wide enough to capture the peaks of two adjacent channels, RBW \geq 1% of the span, VBW) \geq RBW, Sweep = auto, Detector function = peak
2. By using the Max-Hold function record the separation of two adjacent channels.
3. Measure the frequency difference of these two adjacent channels by spectrum analyzer marker function.
4. Repeat above procedures until all frequencies measured were complete.

Limit

Limit kHz
≥25KHz or 2/3 of the 20 dB bandwidth which is greater

GFSK Modulation Limit

Frequency MHz	2/3 of 20 dB Bandwidth kHz
2402	619.40
2441	622.27
2480	616.47

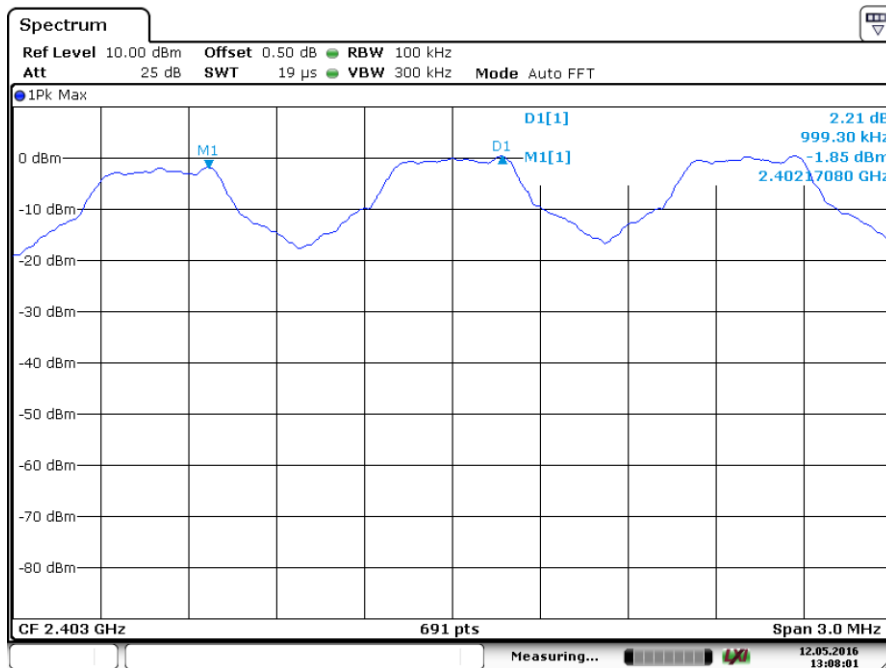
Carrier Frequency Separation

Test result: The measurement was performed with the typical configuration (normal hopping status), here GFSK modulation mode was used to show compliance.

GFSK Modulation test result

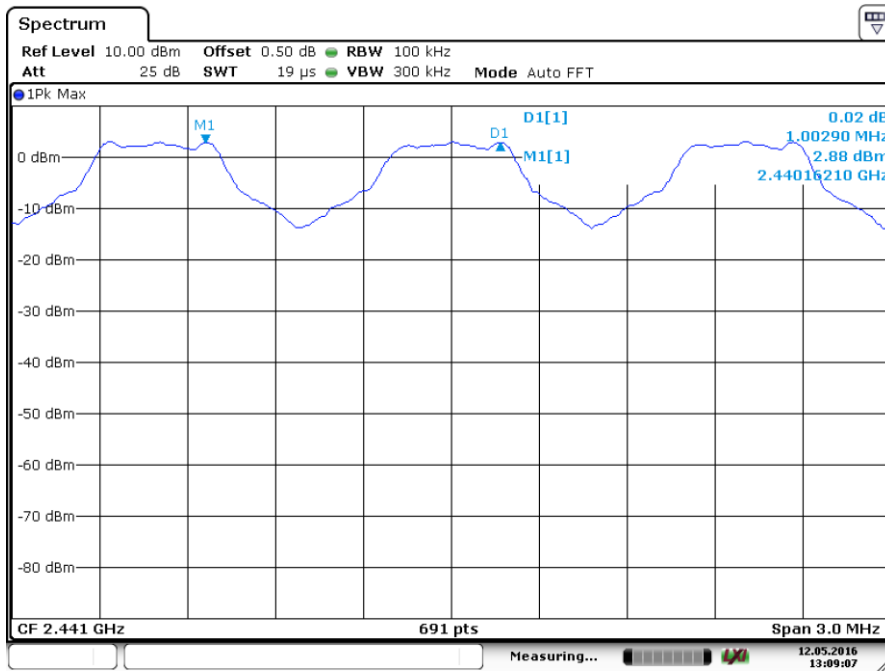
Frequency MHz	Carrier Frequency Separation kHz	Result
2402	1000.0	Pass
2441	1000.0	Pass
2480	1000.0	Pass

Low Channel



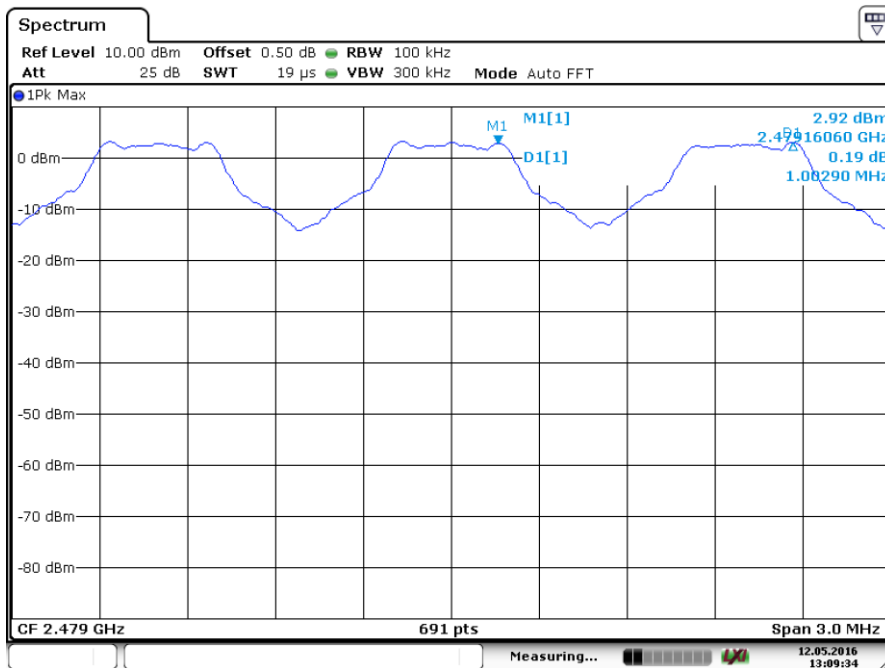
Date: 12.MAY.2016 13:08:01

Middle channel



Date: 12.MAY.2016 13:09:07

High Channel



Date: 12.MAY.2016 13:09:34

9.5 Number of hopping frequencies

Test Method

1. Use the following spectrum analyzer settings:
Span = wide enough to capture the peaks of two adjacent channels, $RBW \geq 1\%$ of the span, $VBW \geq RBW$, Sweep = auto, Detector function = peak
2. Set the spectrum analyzer on Max-Hold Mode, and then keep the EUT in hopping mode.
3. Record all the signals from each channel until each one has been recorded.
4. Repeat above procedures until all frequencies measured were complete.

Limit

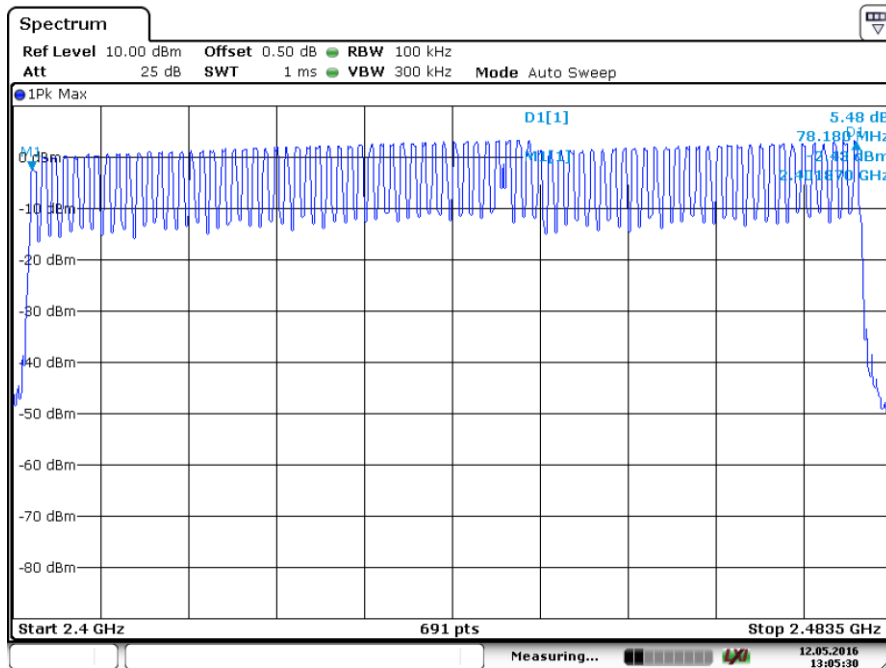
**Limit
number**

≥ 15

Number of hopping frequencies

Test result: The measurement was performed with the typical configuration (normal hopping status), and the total hopping channels is constant for the all modulation mode according with the Bluetooth Core Specification. Here GFSK modulation mode was used to show compliance.

Number of hopping frequencies	Result
79	Pass



Date: 12.MAY.2016 13:05:30

9.6 Dwell Time

Test Method

1. Connect EUT antenna terminal to the spectrum analyzer with a low loss cable.
Equipment mode: Spectrum analyzer
2. RBW: 1MHz; VBW: 1MHz; SPAN: Zero Span
3. Adjust the center frequency of spectrum analyzer on any frequency be measured.
4. Measure the Dwell Time by spectrum analyzer Marker function.
5. Repeat above procedures until all frequencies measured were complete.

Limit

The average time of occupancy on any frequency shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.

Dwell Time

Dwell time

The maximum dwell time shall be 0.4 s.

According to the Bluetooth Core Specification, the worse result (DH5 mode) was reported to show compliance.

The Dwell Time = Burst Width * Total Hops. The detailed calculations are showed as follows:

The duration for dwell time calculation: 0.4 [s] * hopping number = 0.4 [s] * 79 [ch] = 31.6 [s*ch];

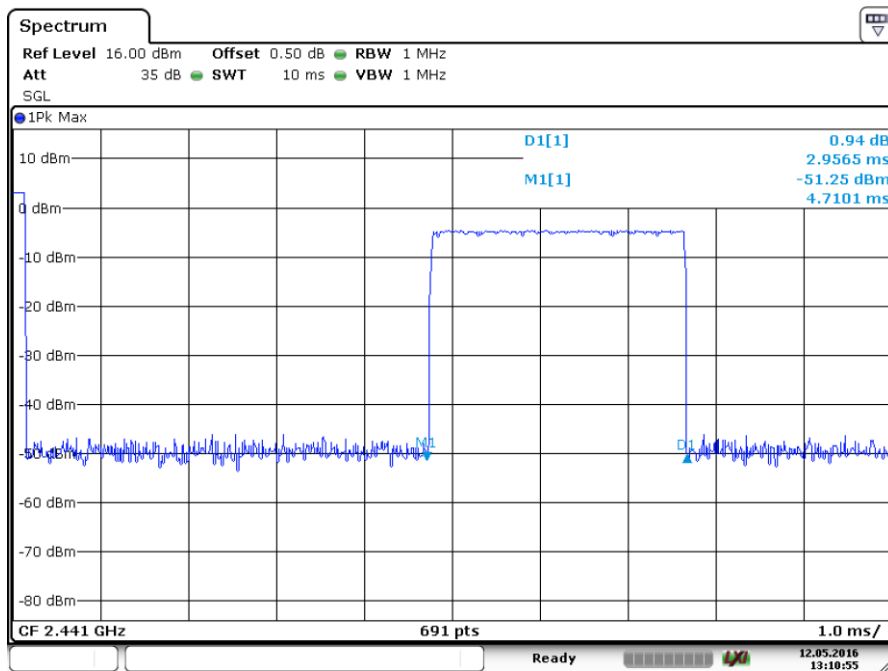
The burst width, which is directly measured, refers to the duration on one channel hop.

The maximum number of hopping channels in 31.6s for DH5=1600 / 6 / 79 *31.6=106.67

Test Result

Modulation	Mode	Reading (ms)	Total Hops	Test Result (ms)	Limit (ms)	Result
GFSK	DH5	2956.5	106.67	315.37	< 400	Pass
$\pi/4$ -DQPSK	2DH5	2985.5	106.67	318.46	< 400	Pass
8-DPSK	3DH5	2956.5	106.67	315.37	< 400	Pass

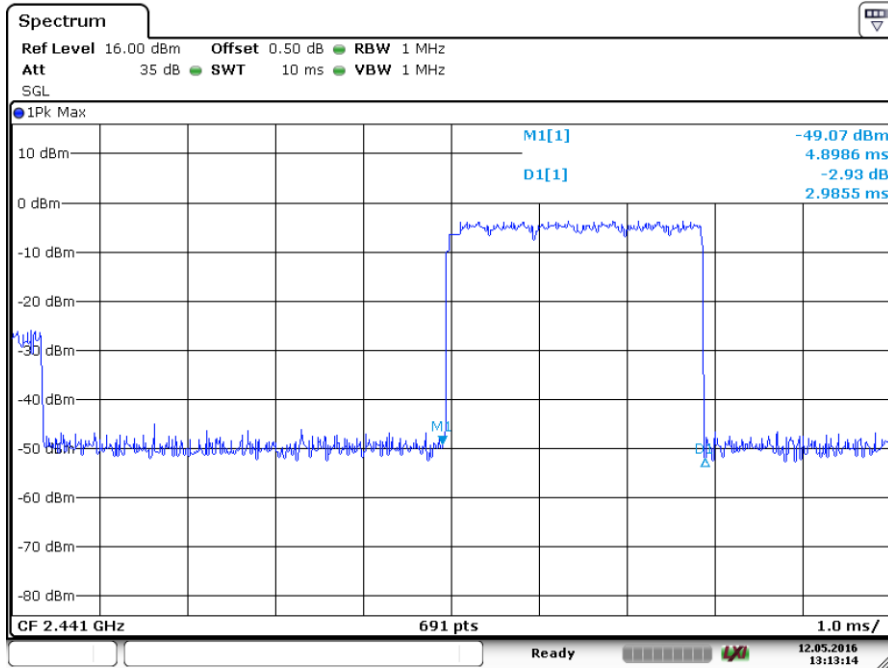
GFSK Modulation



Date: 12.MAY.2016 13:10:56

DH5

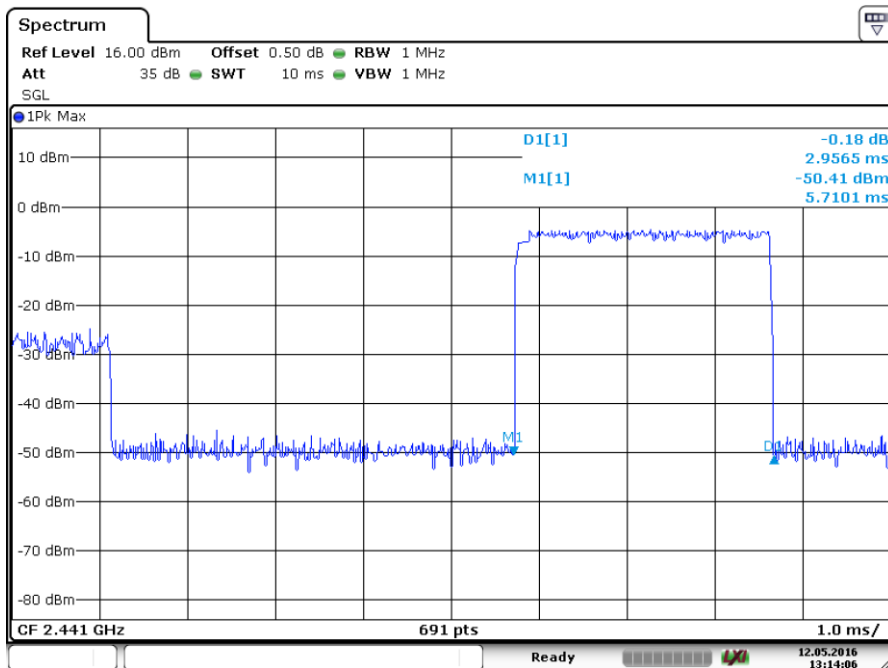
$\pi/4$ -DQPSK Modulation



Date: 12.MAY.2016 13:13:14

2DH5

8-DPSK Modulation



Date: 12.MAY.2016 13:14:06

3DH5

9.7 Spurious RF conducted emissions

Test Method

1. Use the following spectrum analyzer settings:
Span = wide enough to capture the peak level of the in-band emission and all spurious emissions (e.g., harmonics) from the lowest frequency generated in the EUT up through the 10th harmonic. Typically, several plots are required to cover this entire span.
RBW = 100 kHz, VBW ≥ RBW, Sweep = auto, Detector function = peak, Trace = max hold
2. Allow the trace to stabilize. Set the marker on the peak of any spurious emission recorded.
3. The level displayed must comply with the limit specified in this Section. Submit these plots.
4. Repeat above procedures until all frequencies measured were complete.

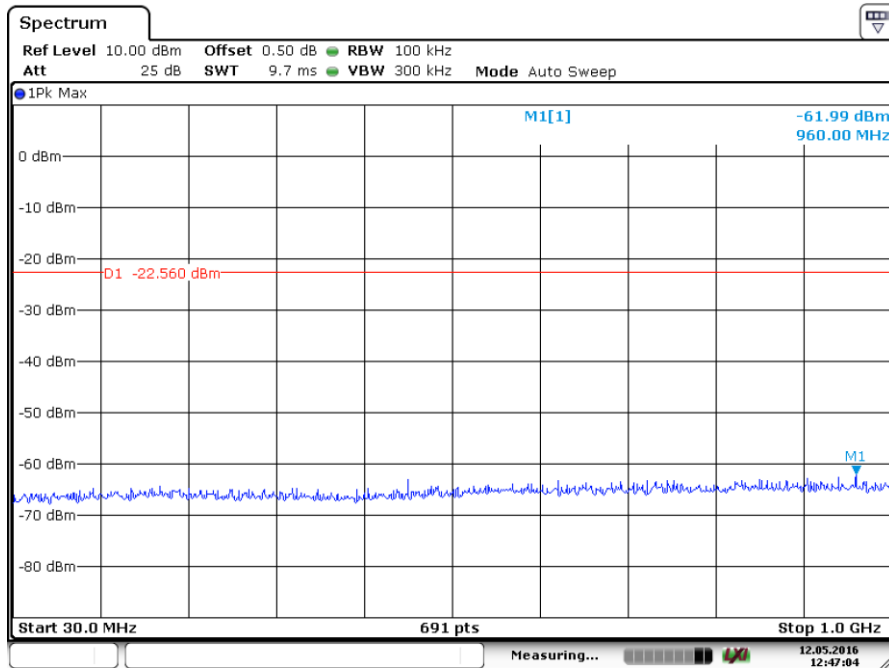
Limit

Frequency Range MHz	Limit (dBc)
30-25000	-20

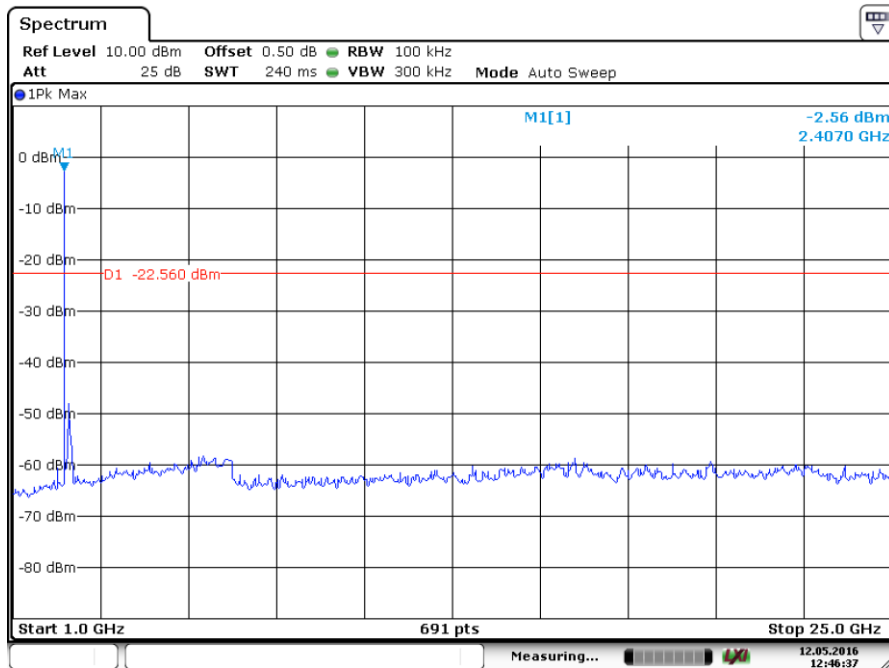
Spurious RF conducted emissions

Only the worst case (which is subject to the maximum EIRP, $\pi/4$ -DQPSK mode) test result is listed in the report.

BT3.0 $\pi/4$ -DQPSK Modulation:
2402MHz

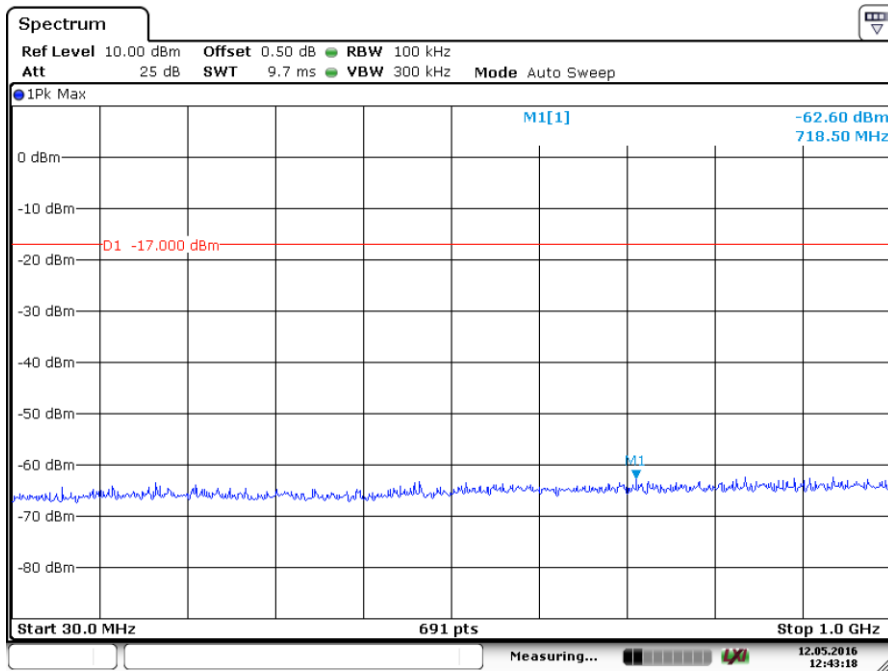


Date: 12.MAY.2016 12:47:04

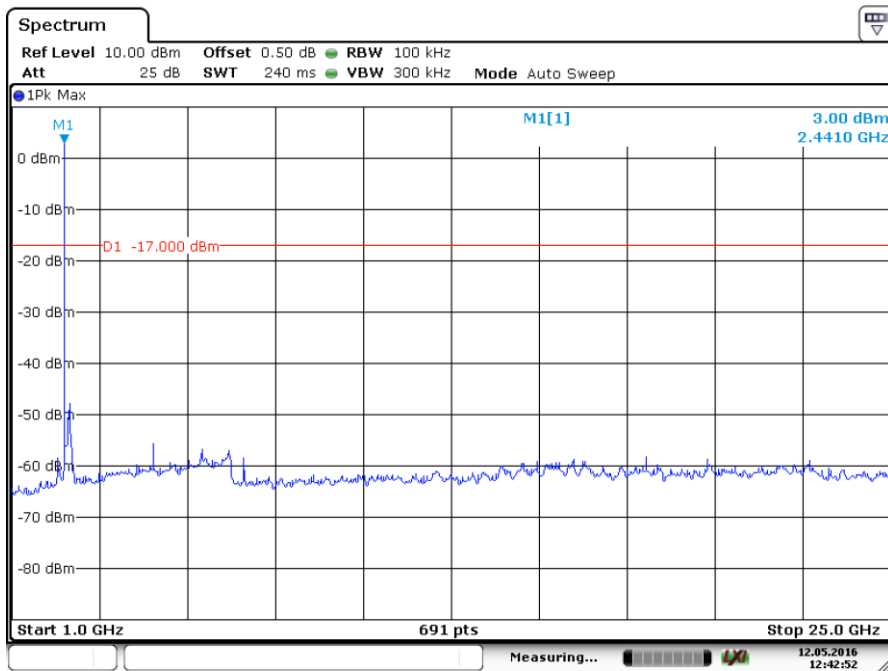


Date: 12.MAY.2016 12:46:38

2441MHz

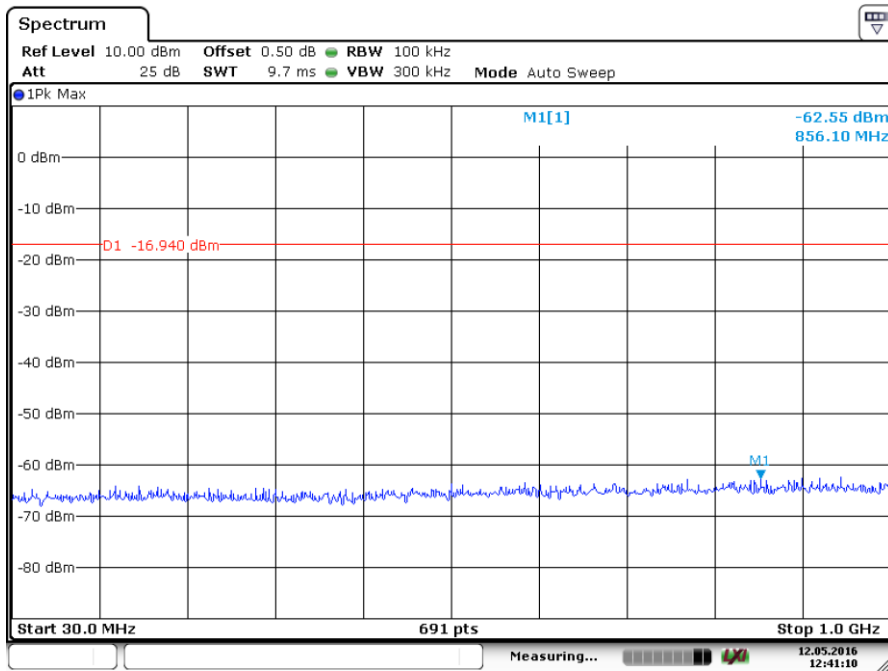


Date: 12.MAY.2016 12:43:18

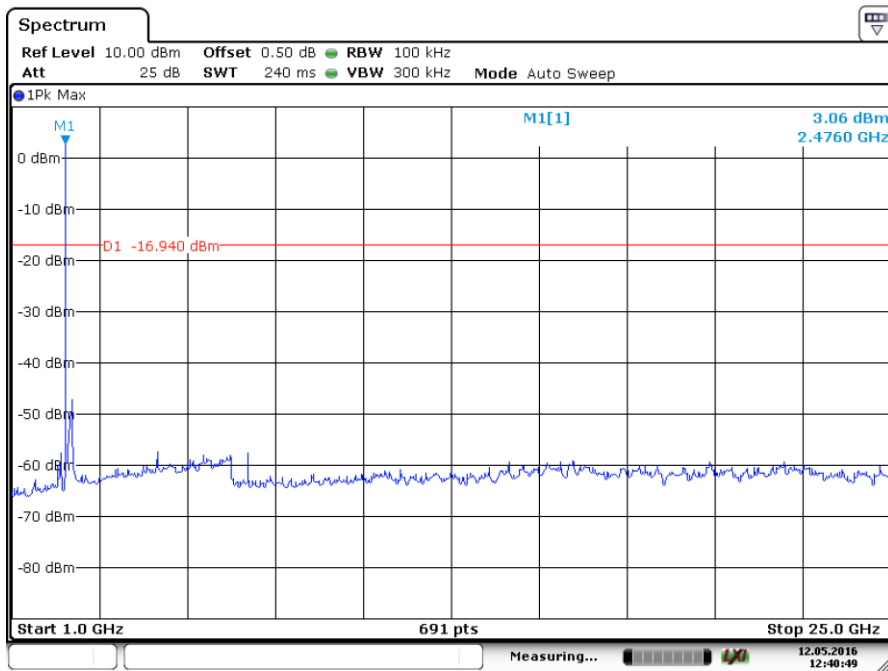


Date: 12.MAY.2016 12:42:52

2480MHz



Date: 12.MAY.2016 12:41:10



Date: 12.MAY.2016 12:40:50

9.8 Band edge testing

Test Method

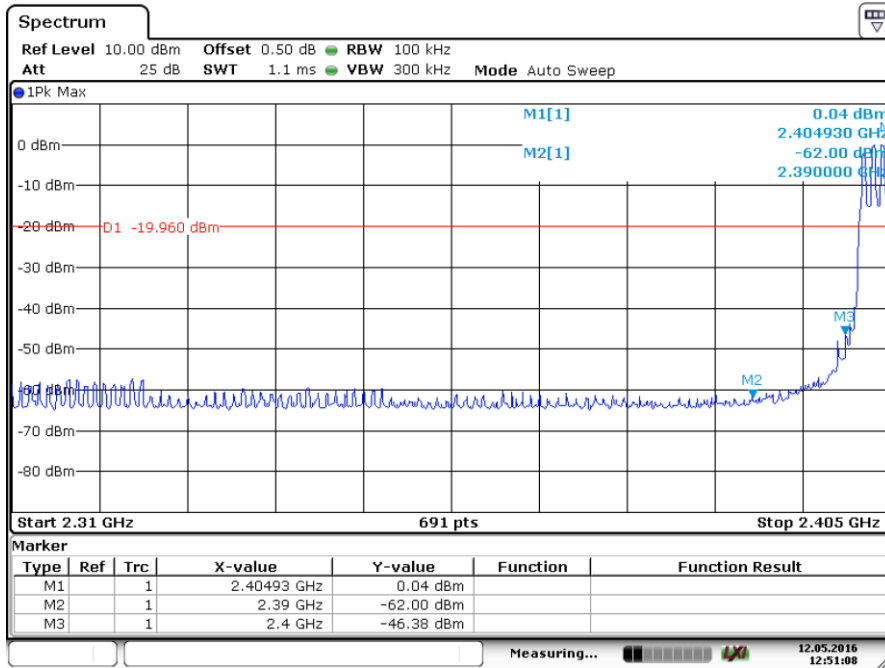
- 1 Use the following spectrum analyzer settings:
Span = wide enough to capture the peak level of the in-band emission and all spurious
RBW = 100 kHz, VBW \geq RBW, Sweep = auto, Detector function = peak, Trace = max hold
- 2 Allow the trace to stabilize, use the peak and delta measurement to record the result.
- 3 The level displayed must comply with the limit specified in this Section. .
- 4 Repeat the test at the hopping off and hopping on mode, submit all the plots.

Limit:

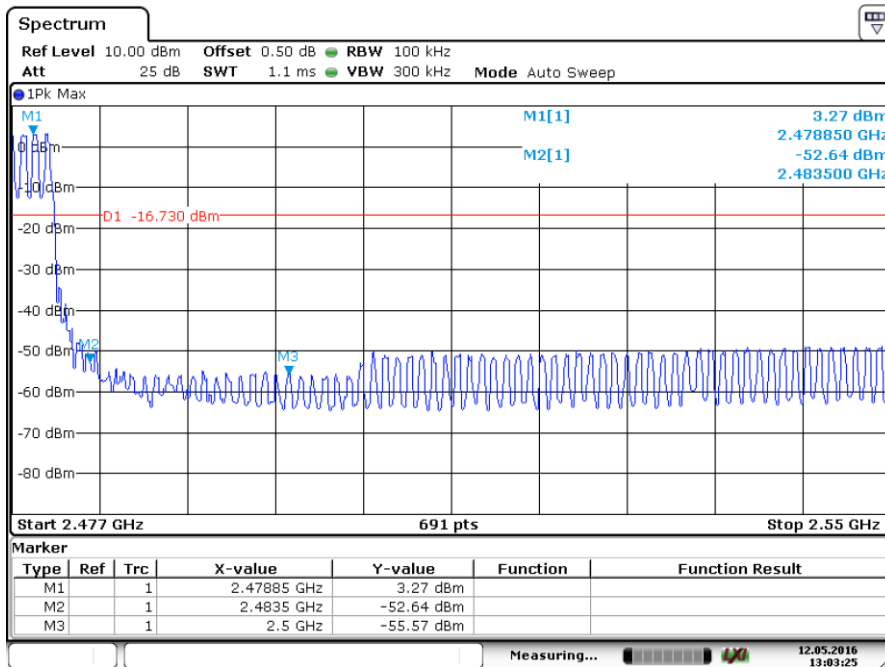
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated device is operating, the RF power that is produced shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided that the transmitter demonstrates compliance with the peak conducted power limits.

Band edge testing

BT3.0 GFSK Modulation Test Result:
Hopping on mode:

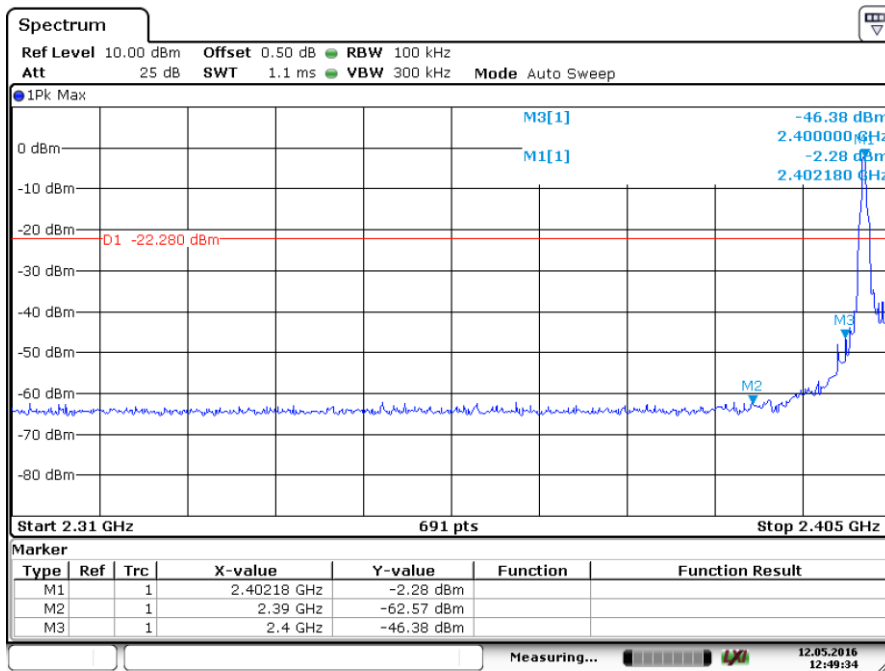


Date: 12.MAY.2016 12:51:08

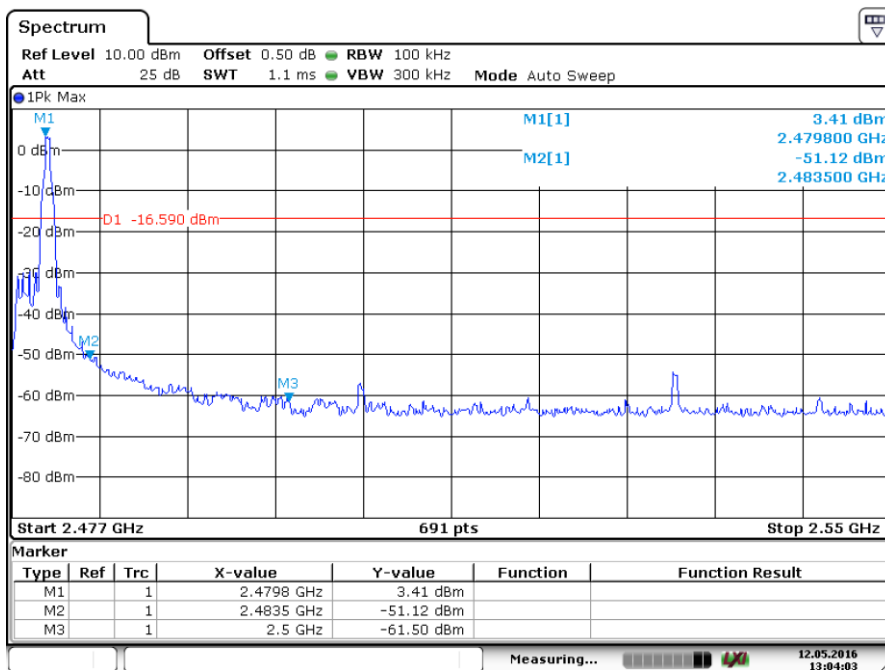


Date: 12.MAY.2016 13:03:25

Hopping off mode:

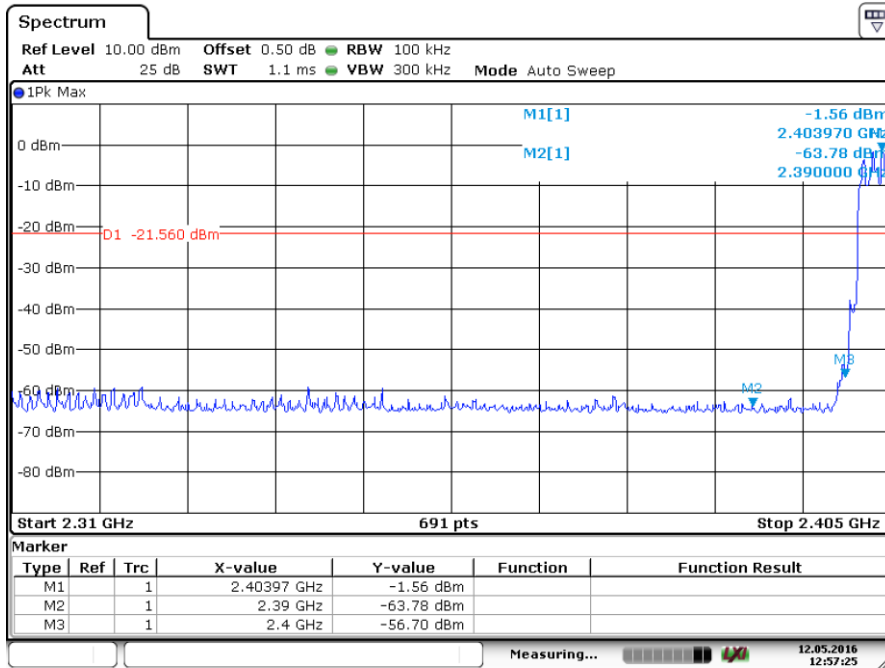


Date: 12.MAY.2016 12:49:34

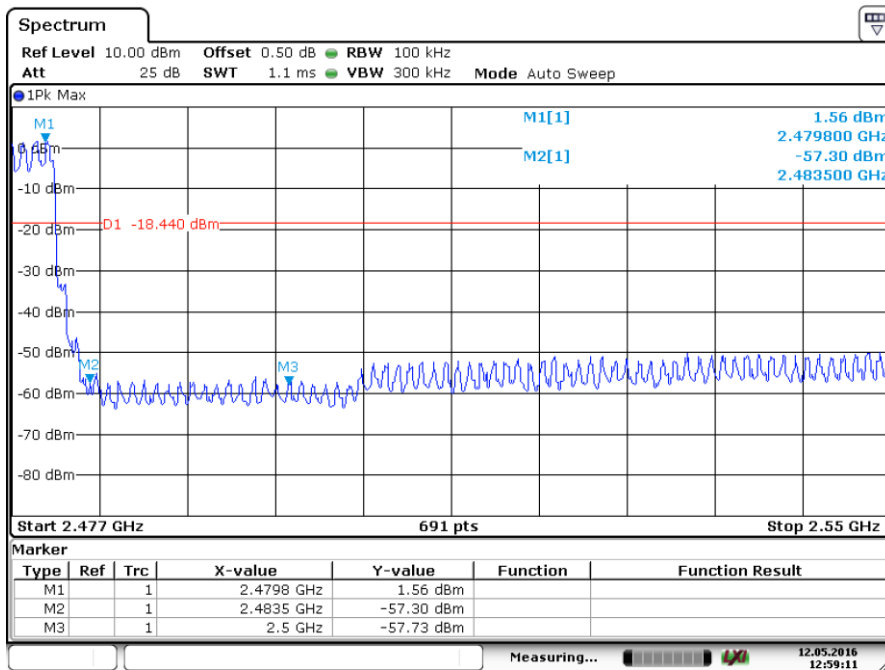


Date: 12.MAY.2016 13:04:03

BT3.0 8-DPSK Modulation Test Result:
Hopping on mode:

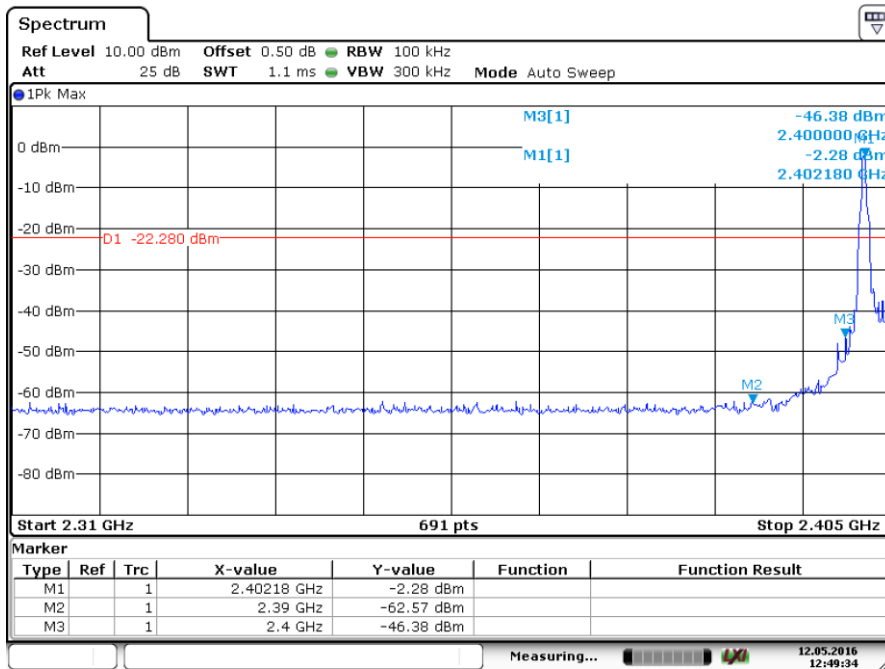


Date: 12.MAY.2016 12:57:25

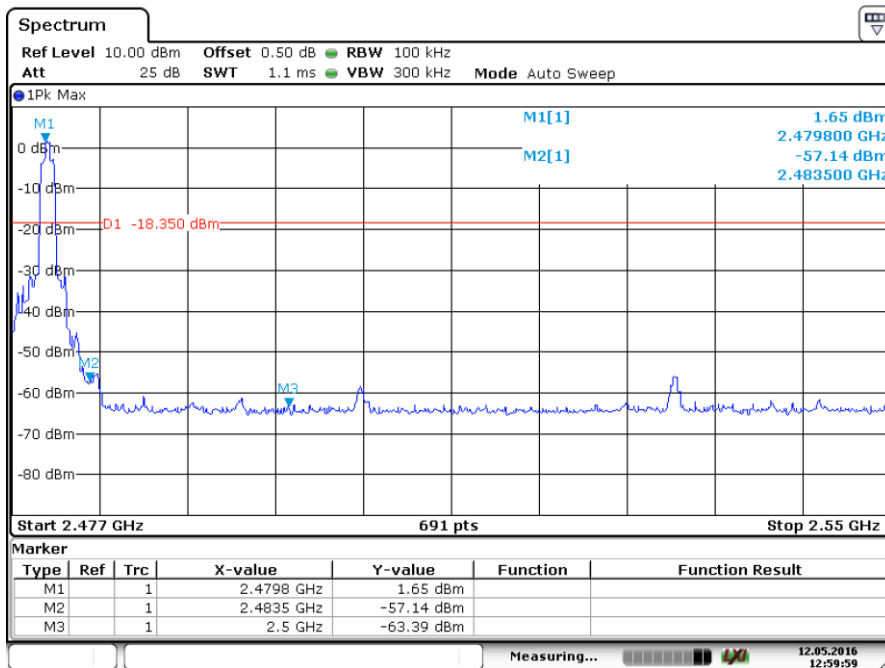


Date: 12.MAY.2016 12:59:11

Hopping off mode:



Date: 12.MAY.2016 12:49:34



Date: 12.MAY.2016 13:00:00

9.9 Spurious radiated emissions for transmitter

Test Method

- 1: The EUT was placed on a turn table which is 1.5m above ground plane for above 1GHz and 0.8m above ground for below 1GHz at 3 meter chamber room for test. The table was rotated 360 degrees to determine the position of the highest radiation.
- 2: The EUT was set 3 meters away from the interference – receiving antenna, which was mounted on the top of a variable – height antenna tower.
- 3: The height of antenna is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- 4: For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- 5: Use the following spectrum analyzer settings According to C63.10:

For Above 1GHz

Span = wide enough to capture the peak level of the in-band emission and all spurious
RBW = 1MHz, VBW \geq RBW for peak measurement and VBW = 10Hz for average measurement, Sweep = auto, Detector function = peak, Trace = max hold.

For Below 1GHz

Use the following spectrum analyzer settings:

Span = wide enough to capture the peak level of the in-band emission and all spurious
RBW = 100 KHz, VBW \geq RBW for peak measurement, Sweep = auto, Detector function = peak, Trace = max hold.

Note:

- 1: The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120 KHz for Quasi-peak detection (QP) at frequency below 1GHz.
- 2: The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and the video bandwidth is 3MHz for peak detection (PK) at frequency above 1GHz.
- 3: The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and the video bandwidth is 3MHz for RMS Average ((duty cycle < 98%) for Average detection (AV) at frequency above 1GHz, then the measurement results was added to a correction factor ($20\log(1/\text{duty cycle})$).
- 4: The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and the video bandwidth is 10Hz (duty cycle > 98%) for Average detection (AV) at frequency above 1GHz.

Limit

The radio emission outside the operating frequency band shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power. Radiated emissions which fall in the restricted bands, as defined in section 15.205, must comply with the radiated emission limits specified in section 15.209.

Frequency MHz	Field Strength uV/m	Field Strength dB μ V/m	Detector
30-88	100	40	QP
88-216	150	43.5	QP
216-960	200	46	QP
960-1000	500	54	QP
Above 1000	500	54	AV
Above 1000	5000	74	PK

Spurious radiated emissions for transmitter

According to C63.10, if the peak (or quasi-peak) measured value complies with the average limit, it is unnecessary to perform an average measurement, so AV emission value did not show in below table if the peak value complies with average limit.

The only worst case (which is subject to the maximum EIRP, $\pi/4$ -DQPSK mode) test result is listed in the report.

Transmitting spurious emission test result as below:

BT3.0 GFSK Modulation 2402MHz Test Result

Frequency Band	Frequency	Emission Level	Polarization	Limit	Detector	Margin	Result
	MHz	dBuV/m		dBuV/m		dBuV/m	
1000-25000MHz	*4804	46.88	H	74	PK	27.12	Pass
	--	--	H	74	PK	--	Pass
	*4804	39.92	V	74	PK	34.08	Pass
	--	--	V	74	PK	--	Pass

BT3.0 GFSK Modulation 2441MHz Test Result

Frequency Band	Frequency	Emission Level	Polarization	Limit	Detector	Margin	Result
	MHz	dBuV/m		dBuV/m		dBuV/m	
30-1000MHz	--	--	H	46	QP	--	Pass
	--	--	H	46	QP	--	Pass
1000-25000MHz	*4882	47.62	H	74	PK	26.38	Pass
	--	--	H	74	PK	--	Pass
	*4882	46.08	V	74	PK	27.92	Pass
	--	--	V	74	PK	--	Pass



BT3.0 GFSK Modulation 2480MHz Test Result

Frequency Band	Frequency	Emission Level	Polarization	Limit	Detector	Margin	Result
	MHz	dBuV/m		dBuV/m		dBuV/m	
1000-25000MHz	*4960	44.58	H	74	PK	29.42	Pass
	--	--	H	74	PK	--	Pass
	*4960	44.23	V	74	PK	29.77	Pass
	--	--	V	74	PK	--	Pass

Remark:

- (1) "*" means the emission(s) appear within the restrict bands shall follow the requirement of section 15.205.

10 Test Equipment List

Site 2:

DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	CAL. DUE DATE
Test Receiver	R & S	ESU26	100050	12-Feb-2017
Bi-conical Antenna	R & S	HK116	100242	07-Dec-2016
Log Periodic Antenna	R & S	HL223	841516/020	01-Sep-2017
Coaxial cable (50ohm)	Rosenberger	RTK081-05S- 05S-10m	LA2-001-10M / 001	01-Sep-2017
Microwave amplifier (0.5-26.5GHz, 25dB gain)	HP	83017A	3123A00437	10-Jun-2016
High Pass Filter (cutoff freq. =1000MHz)	Trilithic	23042	9829213	17-Jul-2016
Horn Antenna	EMCO	3115	9002-3351	28-Oct-2017
Active Loop Antenna	EMCO	6502	9107-2651	26-Aug-2017
RF Voltage Probe	Schwarzbeck	TK9416	None	10-Feb-2017
LISN	R&S	ESH3-Z5	849876/027	15-Jun-2016
Double Shield Cable	Radiall	RG142	Nil	14-Sep-2017
Pulse Limiter	R&S	ESH3-Z2	Nil	04-Jun-2016

11 System Measurement Uncertainty

For a 95% confidence level, the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 were:

System Measurement Uncertainty		
Items		Extended Uncertainty
Radiated Emissions	Level accuracy	±4.68 dB
	30 to 200 MHz	±5.73 dB
	200 to 1000 MHz	±5.57 dB
Conducted Emissions	1000 to 25000 MHz	
	Level accuracy	±3.16 dB
	9 kHz to 30 MHz	
Conducted RF Test		≤ 1 dB